



Recent Advances in Statistical Learning: Theories, Technologies and Environmental & Industrial Applications

Guest Editors:

Dr. Yusen He

Dr. Huajin Li

Dr. Xun Shen

Prof. Dr. Zhenhao Tang

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Message from the Guest Editors

In fact, the foundation of AI is heavily reliant on statistical learning models and theories. Statistical learning from big data or sparse data can be very helpful to investigate intelligent systems' characteristics and guarantee their stability, security, and economic viability.

However, there are still many challenging problems in the statistical learning field that remain unsolved due to the various data formats, more complex data structures, and high sparsity of the data. Thus, new techniques and advanced engineering applications in statistical learning are still appealing to many scholars in the field.

This Special Issue aims to provide selected contributions on recent advances in statistical learning theories, models, and applications. The potential topics include, but not limited to, the following:

- Statistical learning and data driven control intelligent systems;
- Deep learning theory and applications;
- Statistical learning in linear and nonlinear systems;
- Unsupervised statistical learning;
- Deep generative models and related applications;
- Computer vision;
- Natural language processing;
- Deep reinforcement learning.





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Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and
Telecommunications,
Politecnico di Torino, 10129
Torino, Italy

Message from the Editor-in-Chief

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Electronics Editorial Office
MDPI, Grosspeteranlage 5
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